Notice of References Cited Application/Control No. 10/664,105 Examiner Karl J. Puttlitz Applicant(s)/Patent Under Reexamination GLADYSZ ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-			
	В	US-			
	С	US-			
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FOREIGN PATENT DOCUMENTS

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	R					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	υ	Wende et al., Journal of the American Chemical Society, 2001, 123, 1 1490-11491				
	v					
	w					
	x					

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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